

NYC0102BLT1G



Description

This NYC0102 SCR thyristor has been designed for lowpower switching applications by implementing a sensitive gate triggered component.

Features

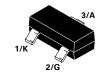
- High dv/dt noise immunity
- Gating Current < 200 µA (micro amp)
- Miniature SOT-23 Package for High Density PCB
- RoHS compliant and Halogen Free/BFR free, Lead-Free

HF Rohs 🕅

Functional Diagram



Pin Out



Additional Information











Maximum Ratings (T = 25°C unless otherwise noted)

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Rating	Symbol	Value	Unit	
Peak Repetitive Off–State Voltage (Note 1) $(R_{GK} = I_{K'}T_J-40 \text{ to }+110^{\circ}\text{C}$, Sine Wave, 50 to 60 Hz)	V _{drm} & V _{rrm}	200	V	
On-State RMS Current (All Conduction Angles; $T_c = 80^{\circ}$ C)	I _{T (RMS)}	0.25	А	
Peak Non-Repetitive Surge Current (1/2 Cycle Sine Wave, 60 Hz, $T_A = 25^{\circ}$ C)	I _{TSM}	7.0	A	
Circuit Fusing Consideration (t = 8.3 ms)	l²t	0.2	A ² sec	
Forward Peak Gate Power (Pulse Width \leq 1.0 sec, $T_{_{A}}$ = 25°C)	P _{GM}	0.1	W	
Forward Average Gate Power (t = 8.3 ms, $T_A = 25^{\circ}C$)	P _{GM (AV)}	0.02	W	
Forward Peak Gate Current (Pulse Width \leq 20 s, $T_{_{\!\!A}}$ = 25°C)	I _{FGM}	0.5	А	
Reverse Peak Gate Voltage (Pulse Width \leq 1.0 s, T _A = 25°C)	V _{RGM}	8.0	V	
Operating Junction Temperature Range @ Rated $\rm V_{\rm \tiny RRM}$ and $\rm V_{\rm \tiny DRM}$	TJ	-40 to +125	°C	
Storage Temperature Range	T _{stg}	-40 to +150	°C	

Thermal Characteristics

Rating	Symbol	Value	Unit
Total Component Dissipation FR–5 Board $T_A = 25^{\circ}C$	P _D	225	mW
Thermal Resistance, Junction-to-Ambient	R _{eja}	380	°C/W

Stresses exceeding Maximum Ratings may damage the component. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect component reliability.

1. V_{Det} and V_{am} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the components are exceeded.

Electrical Characteristics - OFF

Characteristic		Symbol	Min	Тур	Мах	Unit
Peak Repetitive Forward Blocking Current (Note 3) (V_{_{DRM}} =200V, R_{_{GK}} =1 k\Omega)	T」= 25°C T」= 125°C	I _{drm}	-	-	1.0 100	
Peak Repetitive Reverse Blocking Current ($V_{_{\rm RRM}}{=}200V,R_{_{\rm GK}}{=}1k\Omega$)	T _J = 25°C T _J = 125°C	I _{rrm}		-	1.0 100	μΑ

Electrical Characteristics - ON (TJ = 25°C unless otherwise noted)

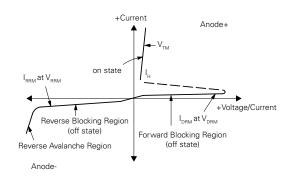
Characteristic	Symbol	Min	Тур	Мах	Unit
Peak Forward On-State Voltage ($I_{TM} = 0.4 \text{ A}, \text{ tp} < 1 \text{ ms}, T_c = 25^{\circ}\text{C}$)	V _{TM}	_	_	1.7	V
Gate Trigger Current ($V_D = 12 V$, $R_L = 100 \Omega$, $T_C = 25^{\circ}C$)	I _{GT}	_	-	200	μA
Gate Trigger Voltage ($V_{D} = 12 \text{ V}, \text{ R}_{L} = 100 \Omega, \text{ T}_{C} = 25^{\circ}\text{C}$)	V _{gt}	_	_	0.8	V
Holding Current (I _T = 50 mA, R _{GK} = 1 k Ω , T _C = 25°C)	I _H	-	_	6.0	mA
Gate Non–Trigger Voltage ($V_{D} = V_{DRM'} R_{L} = 3.3 \text{ k}\Omega, T_{C} = 125^{\circ}\text{C}$)	V _{gd}	0.1	_	-	V
Latching Current (I _g = 1.0 mA, R _{gK} = 1 k Ω , T _c = 25°C)	I _L	-	-	7.0	mA
Gate Reverse Voltage ($I_{RG} = 10 \ \mu A$)	V _{RG}	8.0	_	-	V

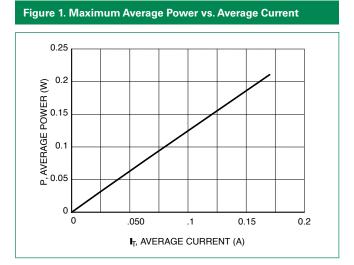
Dynamic Characteristics						
Characteristic	Symbol	Min	Тур	Мах	Unit	
Critical Rate-of-Rise of Off State Voltage ($R_{GK} = 1 \text{ K}\Omega, T_{C} = 125^{\circ}\text{C}$)	dv/dt	200	-	-	V/µs	
Critical Rate of Rise of On–State Current ($I_{cs} = 2xI_{ct}$ 60 Hz, t _r < 100 ns, T _j = 125°C)	di/dt	-	-	50	A/µs	



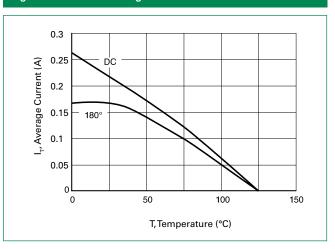
Voltage/Current Characteristics of SCR

Symbol	Parameter
V _{DRM}	Peak Repetitive Forward Off State Voltage
I _{drm}	Peak Forward Blocking Current
V _{RRM}	Peak Repetitive Reverse Off State Voltage
I _{RRM}	Peak Reverse Blocking Current
V _{TM}	Maximum On State Voltage
I _H	Holding Current









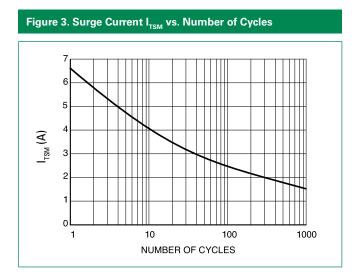


Figure 4. Thermal Response

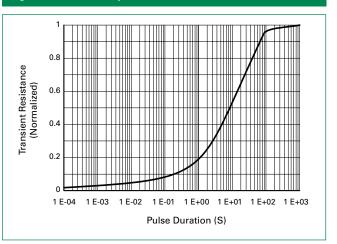




Figure 5. On-State Characteristics

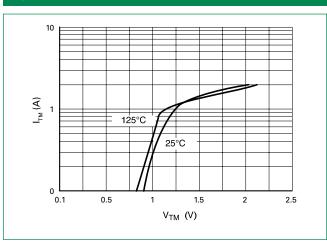


Figure 8. Gate Trigger Current vs. R_{GK}

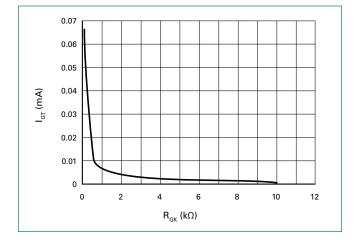


Figure 10. dV/dt vs. R_{GK}

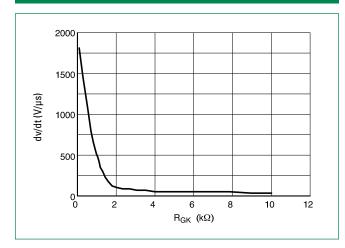


Figure 6. Gate Trigger Current vs. T, (Normalized to 25 C)

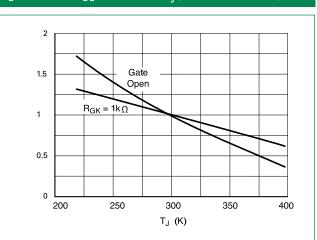


Figure 9. Holding and Latching Current vs.R_{GK}

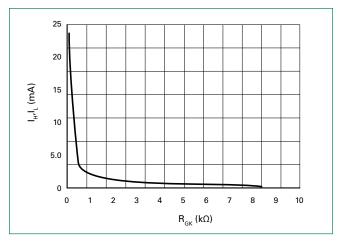
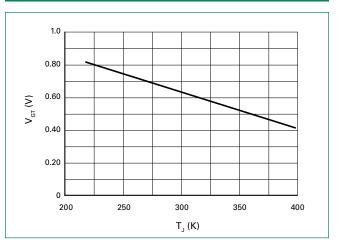
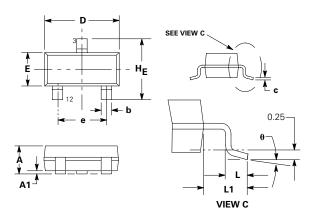


Figure 11. Gate Triggering Voltage vs. T,

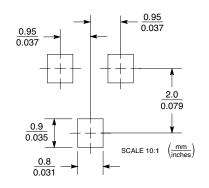




Dimensions



Soldering Footprint



Dim	Inches			Millimeters		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.035	0.041	0.046	0.89	1.03	1.17
A1	0.001	0.004	0.006	0.05	0.10	0.15
b	0.012	0.016	0.020	0.30	0.40	0.50
c	0.003	0.006	0.008	0.08	0.14	0.20
D	0.110	0.114	0.118	2.80	2.90	3.00
Е	0.047	0.051	0.055	1.20	1.30	1.40
е		0.075			1.90	
L	0.016	0.019	0.023	0.40	0.49	0.58
L1	0.018	0.022	0.025	0.46	0.55	0.64
HE	0.083	0.091	0.098	2.10	2.30	2.49
ø	0°		10°	0°		10°

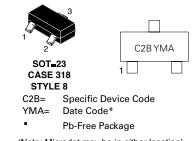
1. Diminishing and tolerancing per ANSIY 14.5M, 1982.

2. Controlling Dimension: Inch

3. Maximum lead thickness includes lead finish thickness. Minimum lead thickness is the minimum thickness of base material.

4. Dimensions D and E do not include mold flash, protrusions, or gate burrs.

Part Marking System



(Note: Microdot may be in either location)

*Date Code orientation and/or overbar may vary depending upon manufacturing location.

Pin Assignment		
1	Cathode	
2	Gate	
3	Anode	

Ordering Information Device Package Shipping SOT-23

(Pb-Free)

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